GSM3385SF

30V P-Channel MOSFETs

Product Description

These P-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

These devices are well suited for high efficiency fast switching applications.

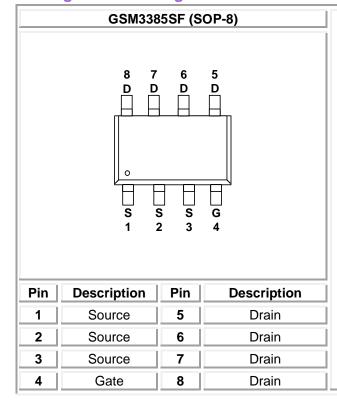
Features

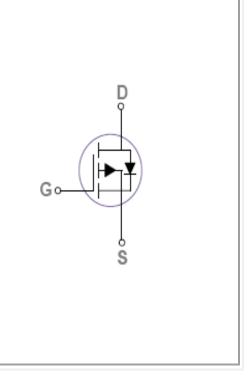
- -30V, -12A, R_{DS(ON)}<9.5mΩ@V_{GS}=-10V
- Fast switching
- Suit for -4.5V Gate Drive Applications
- Green Device Available
- SOP-8 package design

Applications

- MB / VGA / Vcore
- POL Applications
- Load Switch
- LED Application

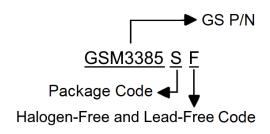
Packages & Pin Assignments





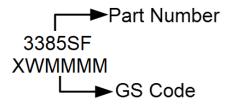


Ordering Information



Part Number	Package	Quantity Reel
GSM3385SF	SOP-8	4000 PCS

Marking Information



Absolute Maximum Ratings T_A=25°C Unless otherwise noted

Symbol	Parameter		Typical	Unit
V _{DS}	Drain-Source Voltage		-30	V
V _{GS}	Gate –Source Voltage		±25	V
ID	Continuous Drain Current	T _A =25°C	-12	
		T _A =70°C	-8.1	Α
Ідм	Pulsed Drain Current		-52	Α
P _D	Power Dissipation (T _A =25°C)		2.1	W
TJ	Operating Junction Temperature Range		-55 to +150	°C
Tstg	Storage Temperature Range		-55 to +150	°C
$R_{\theta JA}$	Thermal Resistance-Junction to Ambient		60	°C/W
R _{eJC}	Thermal Resistance-Junction to Case		30	°C/W



Electrical Characteristics T_A=25°C Unless otherwise noted

Symbol	Parameter	Conditions	Min	Тур	Max	Unit	
		Static					
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =-250uA	-30			V	
$V_{GS(th)}$	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =-250uA	-1.2	-1.6	-2.5	V	
I _{GSS}	Gate Leakage Current	V _{DS} =0V, V _{GS} =±25V			±100	nA	
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =-30V, V _{GS} =0V			-1	uA	
Is	Continuous Source Current	V _G =V _D =0V, Force Current			-13	А	
R _{DS(on)}	Drain-Source On-Resistance	V _{GS} =-10V, I _D =-10A		8.3	9.5	0	
		V _{GS} =-4.5V, I _D =-8A		12.4	14	mΩ	
V _{SD}	Diode Forward Voltage	V _{GS} =0V, I _S =-1A			-1	V	
		Dynamic					
Qg	Total Gate Charge ^{3,4}			68		nC	
Qgs	Gate-Source Charge ^{3,4}	V _{DD} =-15V, V _{GS} =10V, I _D =-15A		10			
Q_{gd}	Gate-Drain Charge ^{3,4}	- ID=-13A		12			
C _{iss}	Input Capacitance			4319			
Coss	Output Capacitance	V_{DS} =-15V, V_{GS} =0V, f=1.0MHz		439		pF	
C _{rss}	Reverse Transfer Capacitance	1- 1.0WII IZ		299			
t _{d(on)}	Turn-On Time			12			
tr	Rise Time	V _{DD} =-15V, V _{GS} =-10V,		11			
t _{d(off)}	Turn-Off Time	Rg=3.3Ω, I _D =-15A		105		ns	
t _f	Fall Time			21			



Typical Performance Characteristics

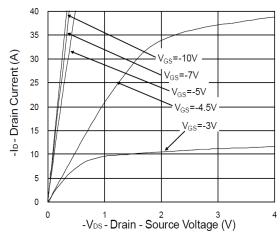


Figure 1. Output Characteristics

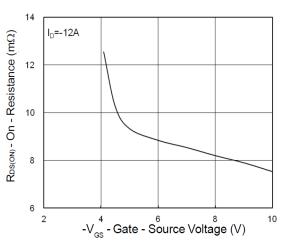


Figure 2. On-Resistance Variation with VGS

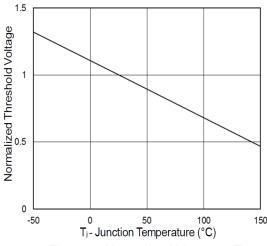


Figure 3. Normalized V_{GS(th)} vs. T_J

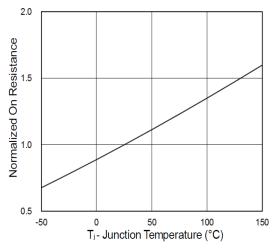


Figure 4. Normalized R_{DSON} vs. T_J

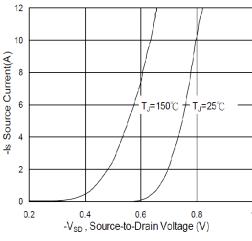


Figure 5. Diode Forward Voltage vs. Current

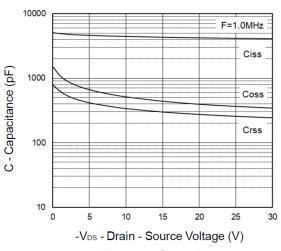


Figure 6. Capacitance

Typical Performance Characteristics (Continue)

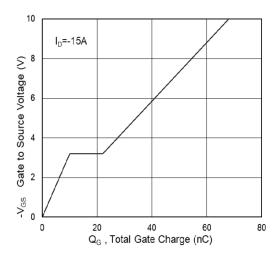


Figure 7. Gate Charge Waveform

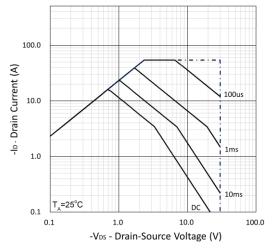


Figure 8. Maximum Safe Operating Area

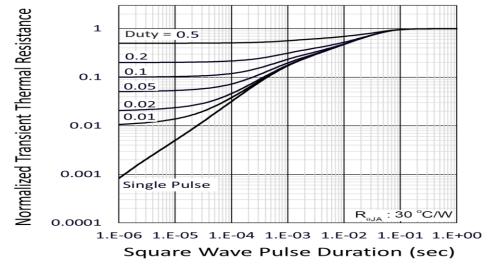
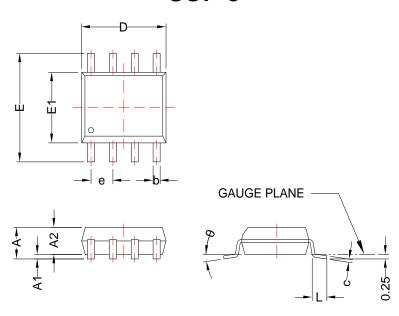


Figure 9. Normalized Transient Thermal Resistance



Package Dimension

SOP-8



DIMENSION D DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.15 mm PER END. DIMENSION E1 DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 mm PER SIDE.

	Dimensions				
Complete I	Millimeters		Inches		
Symbol	Min	Max	Min	Max	
Α		1.75		0.069	
A 1	0.10	0.25	0.004	0.010	
A2	1.25		0.049		
b	0.31	0.51	0.012	0.020	
С	0.10	0.25	0.004	0.010	
D	4.70	5.10	0.185	0.201	
Е	5.80	6.20	0.228	0.244	
E1	3.80	4.00	0.150	0.157	
е	1.27 BSC		0.050 BSC		
L	0.4	1.27	0.016	0.050	
θ	0°	8°	0°	8°	



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